The SMILE-Soft X-ray Imager Charge Distortion Model

Claudio Pagani and the Uni. Leicester SXI Ground Segment team, IACHEC Spring Virtual Workshop, 25/5/2022



Solar wind Magnetosphere Ionosphere Link Explorer: SMILE

SMILE is a collaborative science mission between the European Space Agency (ESA) and the Chinese Academy of Sciences (CAS)



Credit: ESA/NASA

Solar Wind

UV Imager

Earth's Magnetosphere

<u>Orbit</u>:

Apogee ~ 19 RE (~120,000 km) Perigee ~ 1 RE (~6, 000 km) Inclination: ~73° Period: ~51 hours Launch: March 2025 Launcher: Vega-C <u>Nominal Mission Length</u> = 3 Years Maximum Mission Length ~ 7 Years



SMILE Instruments and Spacecraft

Soft X-ray Imager (SXI) PI: Steve Sembay (Uni. Leicester, UK)



Light Ion Analyser (LIA) PI: Lei Dai (NSSC, China)



Magnetometer (MAG) PI: Lei Li (NSSC, China)

Fluxgate Sensors

NSSC: National Space Sciences Centre, Beijing (http://english.nssc.cas.cn)

Ultraviolet Imager (UVI) PI: X. Zhang (NSSC, China)



Therma cutters (N+R)



Platform (CAS)

Launched by ESA on Vega-C







<u>Global imaging using Solar Wind Charge Exchange (SWCX)</u>



Solar Wind: electrons & protons with some (~2%) heavy ions such as carbon, nitrogen and oxygen embedded in the Sun's magnetic field





SWCX: High charge state solar wind ions in collision with hydrogen in the Earth's exosphere to produce photons at X-ray energies

ROSAT All-Sky Survey in 1990 (Scanning observations) SWCX Can be brighter than X-ray background

therefore SWVC X-rays

Hence: magnetopause boundary can be detected using X-ray imaging



SXI observations (simulations)



SXI Charge Distortion Model overview

- based on PLATO CCD270 operated in SXI-like fashion.
- energy emission of the primary SXI science



62% of device detects 300 eV

88% of device detects 300 eV

SXI Charge Distortion Model overview

The SXI CHARGE DISTORTION MODEL (CDM)

O Physical model, based on the standard Shockley-Read-Hall traps theory

- (Oxygen-Vacancy), the Divacancy (2 vacancies), each with a specific energy level E_t and a capture cross section σ
- and a trap release probability $P_r(E_t, T)$



O Charge traps are defects in the CCD silicon lattice. Common defects are the E-centre (Phosphorous-Vacancy), the A-centre

O The capture and the release of an electron by a trap are stochastic processes, described by a capture probability $P_c(\sigma_t, N_e)$



• SXI CDM pixel based

Losses:
$$L = N_{free} P_c$$

Release:
$$N_r = N_0 \left(1 - e^{-\frac{t}{\tau_r}}\right)$$

Flux update: $F(N) = F(N-1) - L + N_r$

Trap species occupancy update.

Includes SXI CCD specific features

Charge injection lines, Pixel Binning (6x6 default), 2nodes output.

O Trap parameters

Four trap species

Trap densities based on measurements from cryogenic CCD280 with EOL irradiation of approximately 3.43x10^9 protons/cm^2 (10 MeV equivalent).

SXI Charge Distortion Model overview

Open University trap-pumping measurements



Release timescale (T = 153K)

- Specie 1, Divacancy ~ 2E-4 s
- Specie 2, E-centre ~ 3.7E+3 s
- Specie 3, Unknown ~ 0.8 s
- Specie 4, O-centre: ~ 1E-6 s

- SXI with 2 large area, back-illuminated Te2v CCD-370.
- Image (3791 rows) and Store (719 rows) sections.
- 2-node output + charge Injection from top of image.
- Range of signal readout times, resulting in different trap species affecting specific areas of the detector:
 - Image exposure: 2.5 s
 - Parallel transfer in image section: 2.7E-5 s
 - Parallel transfer in store section: 1.6E-4 s & 2.7E-3 s
 - Serial transfer: 1.19E-6 s



SXI detectors readout timescales





CDM code applications, so far...

- Use of astrophysical sources to monitor and calibrate gain and CTI on-board.
- Predict CTI losses and spectral distortion (energy losses, line broadening) as a function of epoch, **CCD** temperature, charge injection signal.
- •CDM in SXI CTI correction algorithm.
- Trap parameters determination accuracy to achieve the desired calibration performance.
- Analyse the effects of a diffuse optical background in SXI images.
- Evaluate the "sacrificial charge" effect.

SXI Charge Distortion Model - Applications

SXI CDM - Supernova remnants for CTI measurements

SXI CTI monitoring/calibration on board:

The SXI will observe SNRs serendipitously during a SMILE orbit at various epochs during the mission, with the sources drifting over the detector at various angles/directions.

Procedure to investigate the use of supernova remnants to measure SXI CTI in orbit:

- XSPEC simulated SXI spectra with IACHEC reference model (eg, 1E 0102, N132D) or best fit model of other X-ray missions (eg, Puppis A).
- Process spectra with CDM + special line fitting





Conclusions

- N132D good candidate to verify energy scale after launch and possibly for CTI estimates early on in the mission.
- Puppis A good for monitoring global CTI evolution during the mission, but likely not bright enough to measure the energy scale of single columns.

43:00:00.0 24:00.0 23:00.0 22:00.0 21:00.0 8:20:00.0 19:00.



Puppis A (Dubner et al. 2013), mosaic of XMM/Chandra images



SXI CDM - SXI distorted spectra

SXI CTI damage analysis

Run CDM over one full orbit of simulated SXI observations under different trap parameters and CCD operational configurations to investigate:

- Temperature dependence
- Charge Injection effect
- Time evolution
- Influence of the different trap species



High Energy Particle BG

Include the CDM in an algorithm to derive the observed spectra

Idea: replicate for SXI Chandra's forward-modelling, iterative approach.

measured energy when an event is processed by the CDM

- O = Observed (true) energy
- M = Measured energy
- C = Corrected energy
- D = CDM damaged energy

SXI CDM - CTI corrections

• CDM is run multiple times with incremental refinements to the estimated X-ray events input energies to reproduce the

Iterative algorithm

 $C_n \xrightarrow{\text{CDM}} D_m$, with $C_0 = M$

Repeat until

 $C_n \xrightarrow{\text{CDM}} M$, within a threshold



Results:

- BOL corrections work well, line energies recovered nicely
- EOL corrections more of a struggle. At low energies events end up below the detection threshold.
- Main limitation: information loss in the 6x6 pixel binning.

SXI CDM - CTI corrections



SXI CDM - Trap parameters accuracy

With what accuracy do we need to measure the trap parameters? => Run CDM CTI correction algorithm offsetting input trap parameters.



Conclusions:

• Corrections least affected by traps release timescale inaccuracy • Corrections very sensitive to beta (the charge volume coefficient parameter, that constrains the CTI energy dependence)





SXI CDM - Temperature, diffuse background, sacrificial charge effects

The CDM has been used to investigate how different effects can impact CTI, by exploring trap parameters range and various SXI CCD operational settings

- Charge Injection ON/OFF
- CCD temperature
- Diffuse optical background
- Sacrificial charge effect

Diffuse background



SXI CDM - Temperature, diffuse background, sacrificial charge effects

Temperature + Sacrificial charge effects





O Summary:

- The SXI CDM has been used to model and predict a number of CTI-related effects.
- University to study CTI and determine more accurate trap parameters.

O Current limitations:

- Rixel based implementation is very slow (~8hrs to process SXI observations over a full orbit)
- the introduction of multiple ad-hoc trap species, slowing the CDM down even more.

O Conclusions:

- The CDM is a useful tool to model CTI and study the effects of different configurations/CCD operations.
- * CDM might not turn out to be the best/practical tool to "correct" CTI effects on board.
- * An alternative, more light-weight, functional approach might eventually be needed in the SXI pipeline.

SXI CDM - Conclusions

These analysis will be repeated after irradiation of an SMILE CCD370 and a calibration campaign by the Open

Cryogenic irradiation of a PLATO CCD280 shows the emergence of a continuum of defects, without well determined emission timescales. This is a concern for the CDM, and it would require a modification of the code, or